

Description:

This N+P Channel MOSFET uses advanced trench technology and

design to provide excellent $R_{DS(on)}$ with low gate charge.

It can be used in a wide variety of applications.

Features:

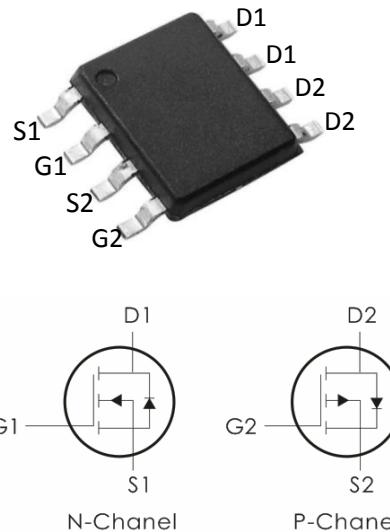
N-Channel: $V_{DS}=60V, I_D=4.5A, R_{DS(ON)}<40m\Omega @ V_{GS}=10V$

P-Channel: $V_{DS}=-60V, I_D=-4.1A, R_{DS(ON)}<90m\Omega @ V_{GS}=-10V$

1) High Power and current handing capability.

2) Lead free product is acquired.

3) Surface Mount Package.



Absolute Maximum Ratings: ($T_c=25^\circ C$ unless otherwise noted)

Symbol	Parameter	N-Channel	P-Channel	Units
V_{DS}	Drain-Source Voltage	60	-60	V
V_{GS}	Gate-Source Voltage	± 20	± 20	V
I_D	Drain Current-Continuous @ $T_A=25^\circ C^1$	4.5	-4.1	A
	Drain Current-Continuous @ $T_A=70^\circ C^1$	3.5	-3.2	
I_{DM}	Pulsed Drain Current ⁻²	18	-14	
EAS	Single Pulse Avalanche Energy ³	22	29.7	mJ
I_{AS}	Avalanche Current	21	24.2	A
P_D	Power Dissipation ⁴	1.5	1.5	W
T_J, T_{STG}	Operating and Storage Junction Temperature Range	-55 to +150	-55 to +150	°C

Thermal Characteristics:

Symbol	Parameter	N-Channel Max	P-Channel Max	Units
$R_{\Theta JA}$	Thermal Resistance,Junction to Ambient ¹	85	85	°C/W
$R_{\Theta JAC}$	Thermal Resistance,Junction Case ¹	25	25	

Part NO.	Marking	Package
FDS4559-NL	FDS4559-NL	SOP-8

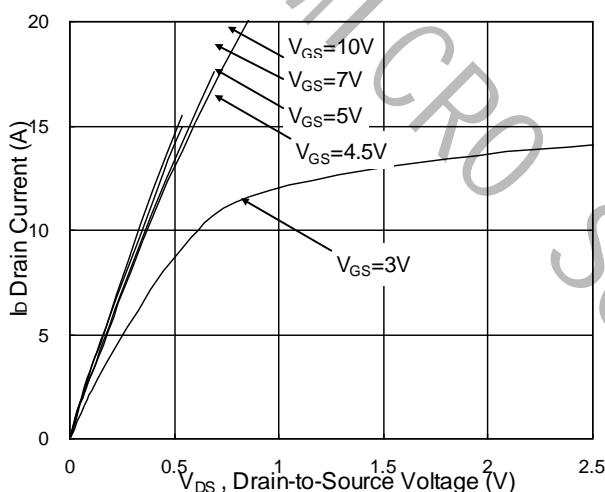
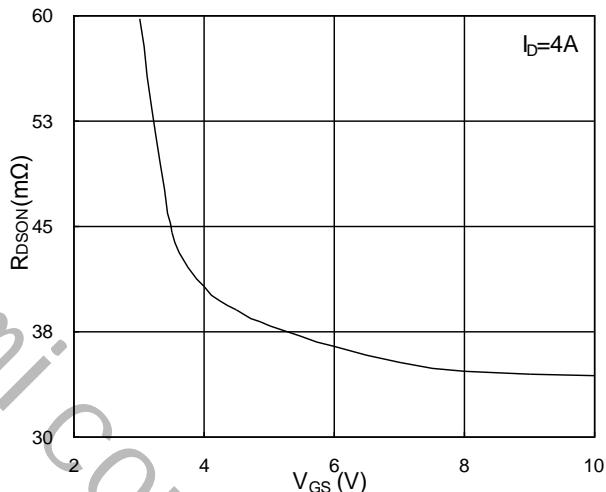
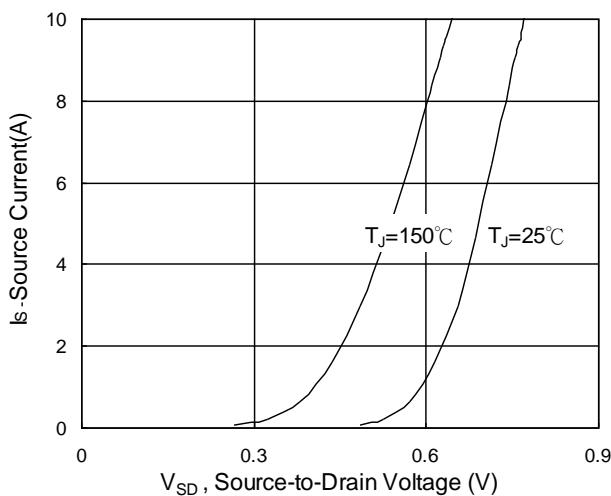
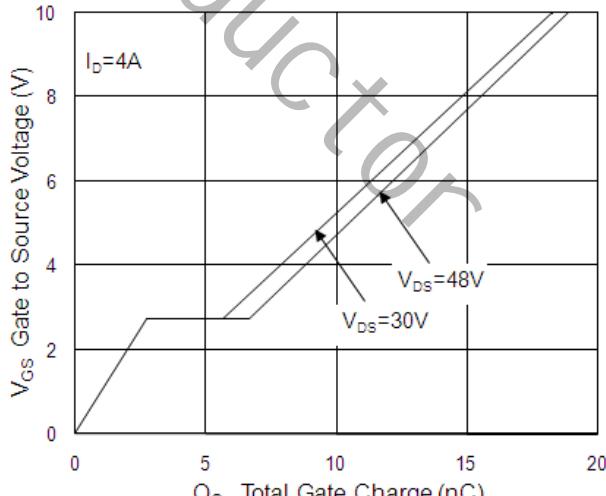
N-Channel Electrical Characteristics: ($T_C=25^\circ\text{C}$ unless otherwise noted)

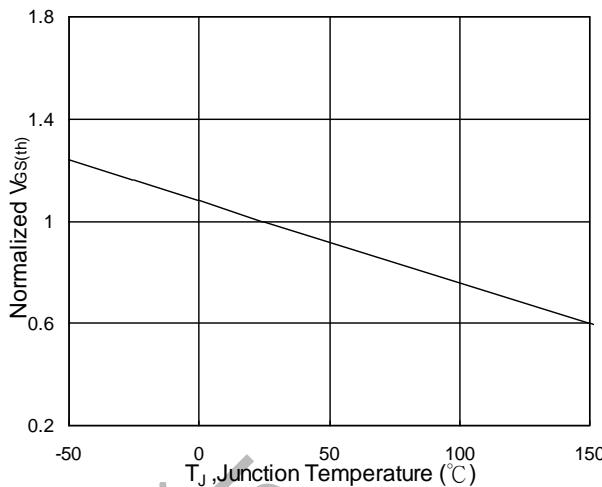
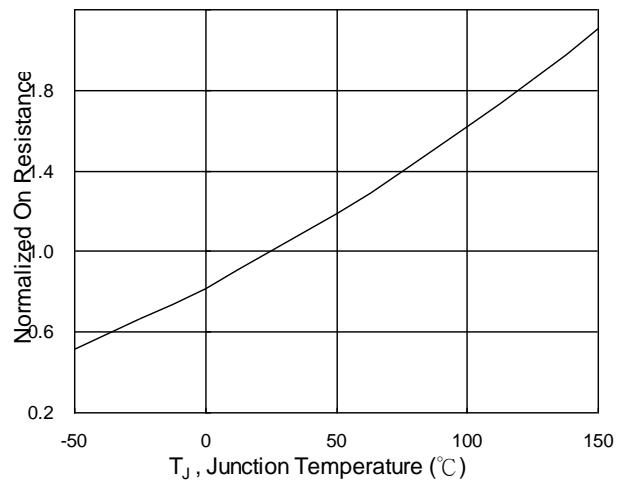
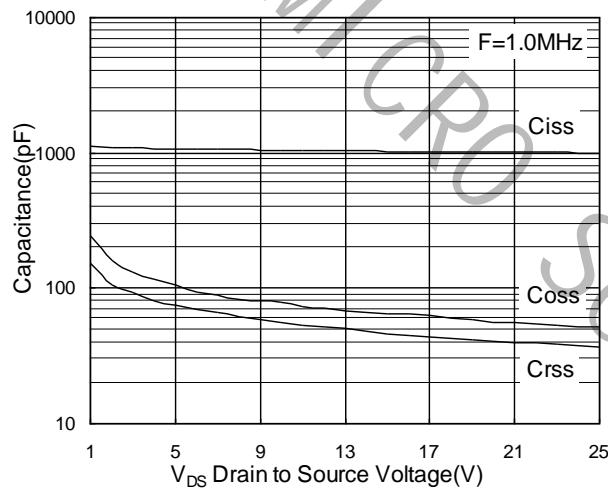
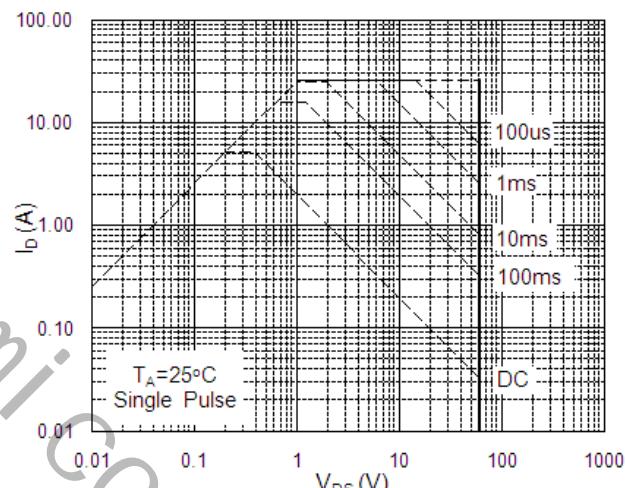
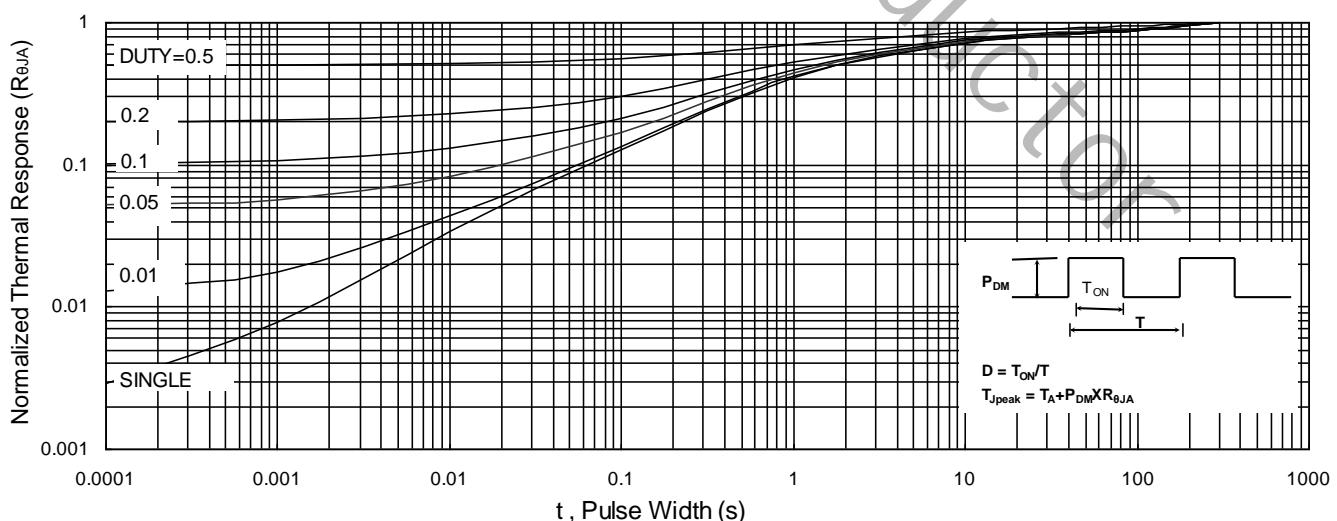
Symbol	Parameter	Conditions	Min	Typ	Max	Units
ON/Off Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=250 \mu\text{A}$	60	---	---	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{\text{GS}}=0\text{V}, V_{\text{DS}}=48\text{V}$	---	---	1	μA
I_{GSS}	Gate-Source Leakage Current	$V_{\text{GS}}=\pm 20\text{V}, V_{\text{DS}}=0\text{A}$	---	---	± 100	nA
On Characteristics						
$V_{\text{GS}(\text{th})}$	GATE-Source Threshold Voltage	$V_{\text{GS}}=V_{\text{DS}}, I_{\text{D}}=250 \mu\text{A}$	1	---	2.5	V
$R_{\text{DS}(\text{ON})}$	Drain-Source On Resistance ²	$V_{\text{GS}}=10\text{V}, I_{\text{D}}=4\text{A}$	---	---	40	$\text{m}\Omega$
		$V_{\text{GS}}=4.5\text{V}, I_{\text{D}}=3\text{A}$	---	---	50	
G_{FS}	Forward Transconductance	$V_{\text{DS}}=5\text{V}, I_{\text{D}}=4\text{A}$	---	28.3	---	S
R_{g}	Gate Resistance	$V_{\text{DS}}=0\text{V}, V_{\text{GS}}=0\text{V}, f=1\text{MHz}$	---	2.5	---	Ω
Dynamic Characteristics						
C_{iss}	Input Capacitance	$V_{\text{DS}}=15\text{V}, V_{\text{GS}}=0\text{V}, f=1\text{MHz}$	---	1027	---	pF
C_{oss}	Output Capacitance		---	65	---	
C_{rss}	Reverse Transfer Capacitance		---	46	---	
Switching Characteristics						
$t_{\text{d}(\text{on})}$	Turn-On Delay Time	$V_{\text{DD}}=30\text{V}, I_{\text{D}}=4\text{A}$ $V_{\text{GS}}=10\text{V}, R_{\text{G}}=3.3\Omega$	---	3	---	ns
t_r	Rise Time		---	34	---	ns
$t_{\text{d}(\text{off})}$	Turn-Off Delay Time		---	23	---	ns
t_f	Fall Time		---	6	---	ns
Q_g	Total Gate Charge (4.5V)	$V_{\text{GS}}=10\text{V}, V_{\text{DS}}=48\text{V}, I_{\text{D}}=4\text{A}$	---	19	---	nC
Q_{gs}	Gate-Source Charge		---	2.6	---	nC
Q_{gd}	Gate-Drain "Miller" Charge		---	4.1	---	nC
Drain-Source Diode Characteristics						
V_{SD}	Source-Drain Diode Forward Voltage ²	$V_{\text{GS}}=0\text{V}, I_{\text{S}}=1\text{A}, T_J=25^\circ\text{C}$	---	---	1.2	V

I_S	Continuous Source Current ^{1,5}	$V_G=V_D=0V$	---	---	4.5	A
I_{SM}	Pulsed Source Current ^{2,5}		---	---	18	
t_{rr}	Reverse Recovery Time	$I_F=4A, \frac{dI}{dt}=100A/\mu s, T_J=25^\circ C$	---	12.1	---	nS
Q_{rr}	Reverse Recovery Charge		---	6.7	---	nC

Notes:

- 1.The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- 2.The data tested by pulsed , pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$
- 3.The EAS data shows Max. rating . The test condition is $V_{DD}=25V, V_{GS}=10V, L=0.1mH, I_{AS}=21A$
- 4.The power dissipation is limited by $150^\circ C$ junction temperature
- 5.The data is theoretically the same as I_D and I_{DM} , in real applications , should be limited by total power dissipation.

Typical Characteristics: ($T_c=25^\circ C$ unless otherwise noted)

Fig.1 Typical Output Characteristics

Fig.2 On-Resistance vs. Gate-Source

Fig.3 Forward Characteristics Of Reverse

Fig.4 Gate-Charge Characteristics


Fig.5 Normalized $V_{GS(th)}$ vs. T_J

Fig.6 Normalized $R_{DS(on)}$ vs. T_J

Fig.7 Capacitance

Fig.8 Safe Operating Area

Fig.9 Normalized Maximum Transient Thermal Impedance

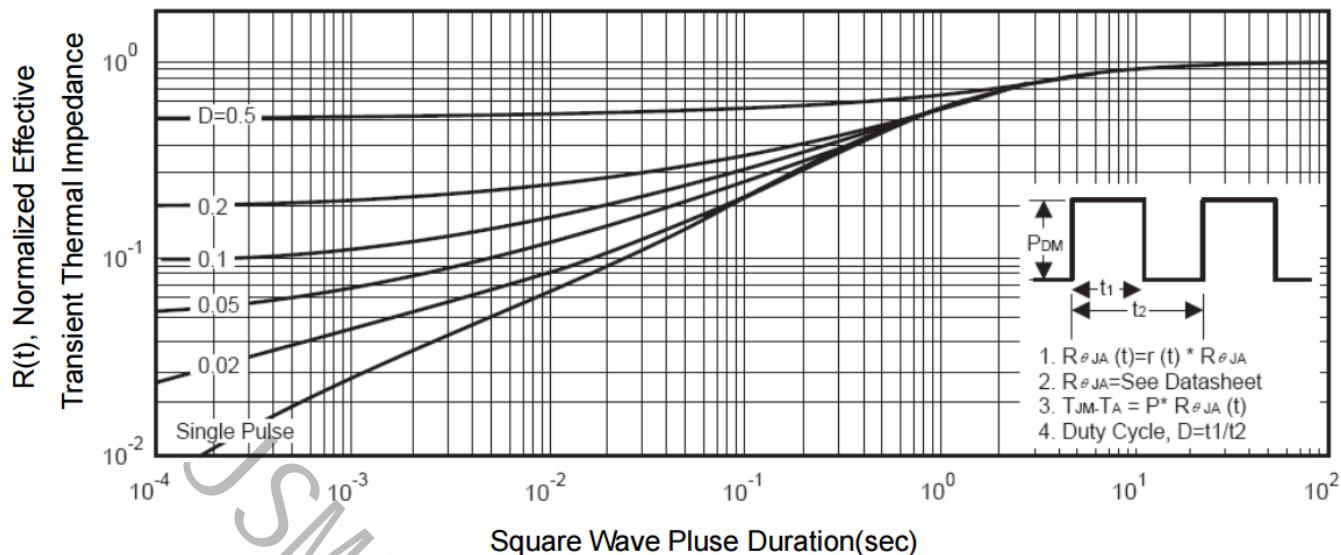


Figure 11. Normalized Maximum Transient Thermal Impedance

P-Channel Electrical Characteristics: ($T_C=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
ON/Off States						
$\mathbf{BV}_{\mathbf{DSS}}$	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=-250 \mu\text{A}$	-60	---	---	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{GS}=0V, V_{DS}=-48V$	---	---	1	μA
I_{GSS}	Gate-Source Leakage Current	$V_{GS}=\pm 20V, V_{DS}=0A$	---	---	± 100	nA
On Characteristics³						
$V_{GS(\text{th})}$	GATE-Source Threshold Voltage	$V_{GS}=V_{DS}, I_D=-250 \mu\text{A}$	-1.2	---	-2.5	V
$R_{DS(\text{ON})}$	Drain-Source On Resistance ²	$V_{GS}=-10V, I_D=-3A$	---	---	90	$\text{m}\Omega$
		$V_{GS}=-4.5V, I_D=-2A$	---	---	125	
G_{FS}	Forward Transconductance	$V_{DS}=-5V, I_D=-3A$	---	8.7	---	S
R_g	Gate Resistance	$V_{DS}=0V, V_{GS}=0V, f=1\text{MHz}$	---	15	---	Ω
Dynamic Characteristics						
C_{iss}	Input Capacitance	$V_{DS}=-15V, V_{GS}=0V, f=1\text{MHz}$	---	900	---	pF
C_{oss}	Output Capacitance		---	65	---	
C_{rss}	Reverse Transfer Capacitance		---	47	---	
Switching Characteristics						
$t_{d(on)}$	Turn-On Delay Time	$V_{DD}=-15V, V_{GS}=-10V,$	---	8.8	---	ns

t_r	Rise Time	$R_{GEN}=3.3\ \Omega, I_D=-1A$	---	19.6	---	ns
$t_{d(off)}$	Turn-Off Delay Time		---	47.2	---	ns
t_f	Fall Time		---	9.6	---	ns
Q_g	Total Gate Charge (-4.5V)	$V_{GS}=-4.5V, V_{DS}=-48V, I_D=-3A$	---	10	---	nC
Q_{gs}	Gate-Source Charge		---	1.9	---	nC
Q_{gd}	Gate-Drain "Miller" Charge		---	6.5	---	nC

Drain-Source Diode Characteristics

V_{SD}	Source-Drain Diode Forward Voltage ³	$V_{GS}=0V, I_S=-6.5A$	---	---	-1.2	V
I_S	Continuous Source Current ^{1,5}	$V_G=V_D=0V,$	---	---	-4.1	A
I_{SM}	Diode Forward Voltage ²		---	---	-14	

Notes:

1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
2. The data tested by pulsed , pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$
3. The EAS data shows Max. rating . The test condition is $V_{DD}=-25V, V_{GS}=-10V, L=0.1mH, I_{AS}=-24.4A$
4. The power dissipation is limited by 150°C junction temperature
5. The data is theoretically the same as I_D and I_{DM} , in real applications , should be limited by total power dissipation.

Typical Characteristics: ($T_C=25^\circ C$ unless otherwise noted)

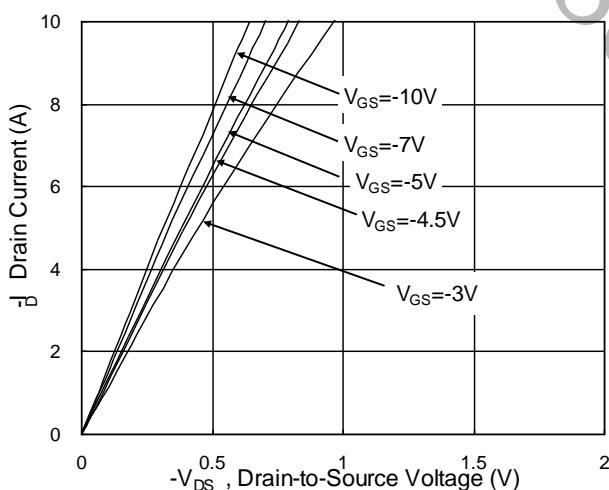


Fig.1 Typical Output Characteristics

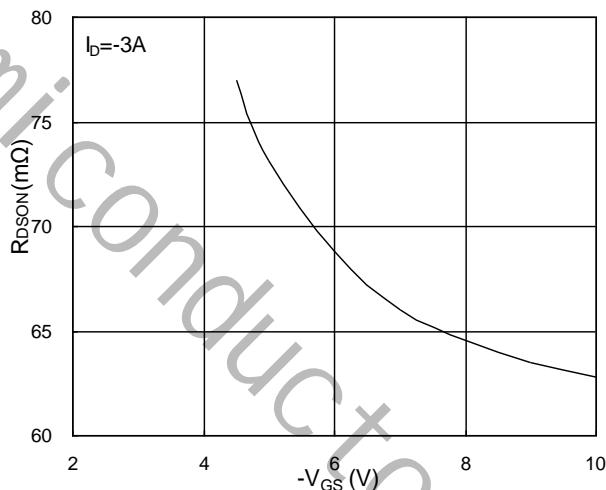


Fig.2 On-Resistance v.s Gate-Source

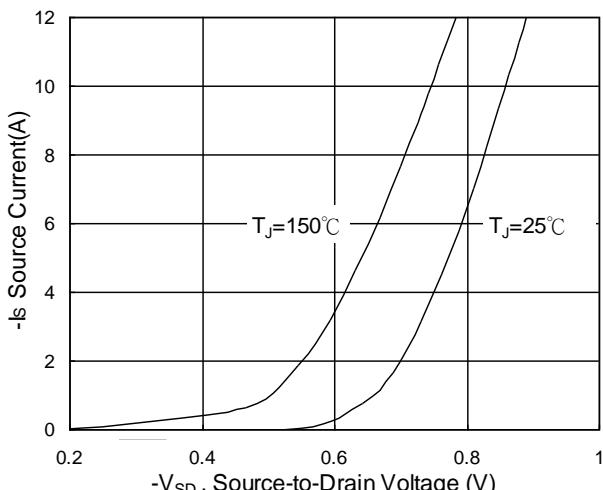


Fig.3 Forward Characteristics of Reverse

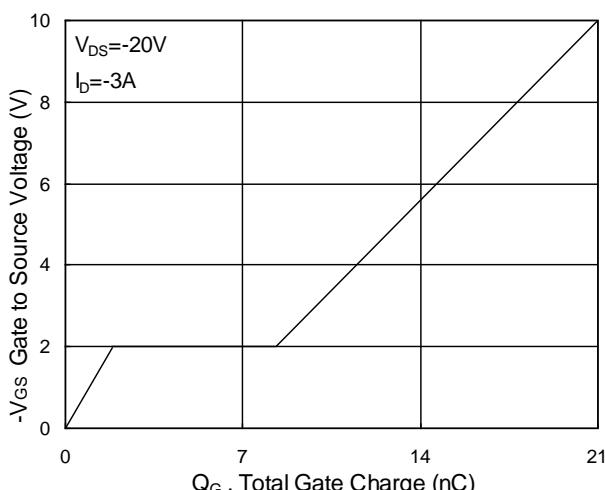
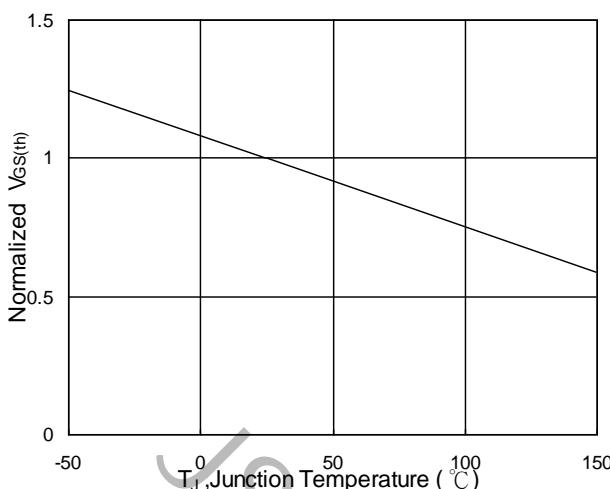
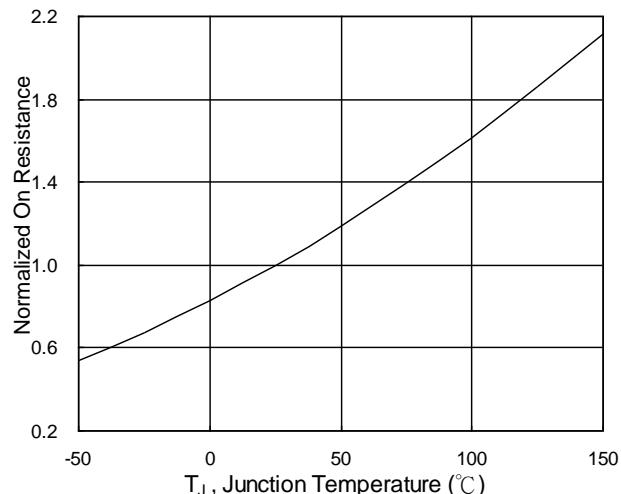
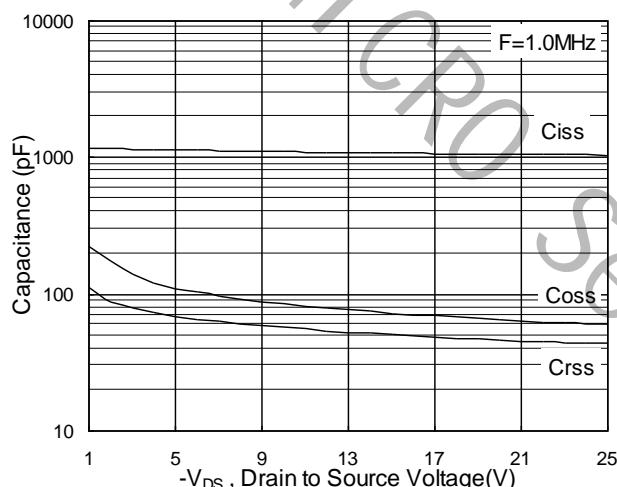
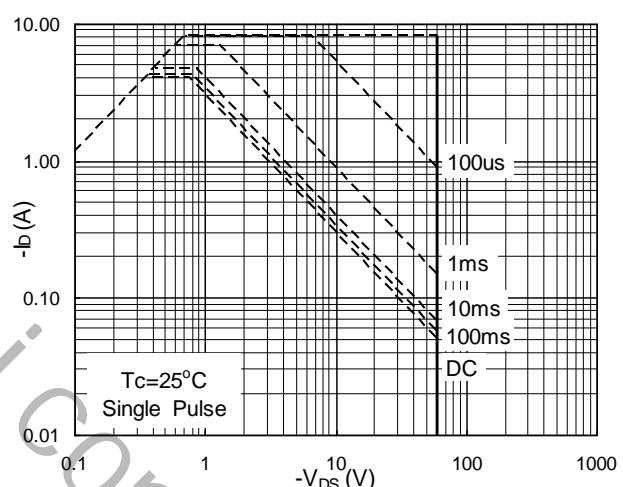
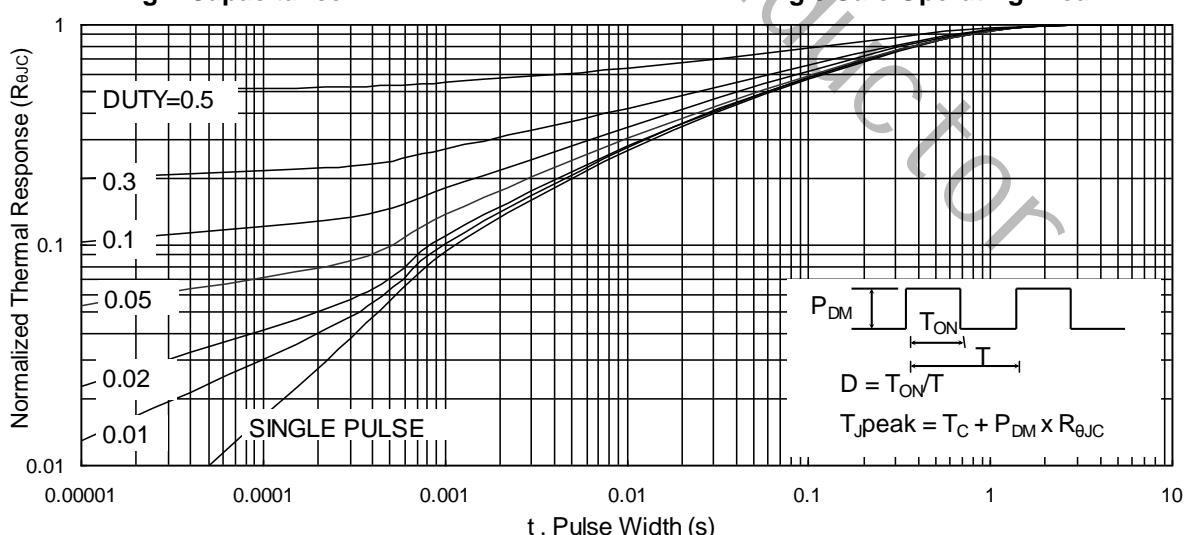


Fig.4 Gate-Charge Characteristics


Fig.5 Normalized $V_{GS(th)}$ vs. T_J

Fig.6 Normalized $R_{DS(on)}$ vs. T_J

Fig.7 Capacitance

Fig.8 Safe Operating Area

Fig.9 Normalized Maximum Transient Thermal Impedance